Notice of R ferences Cited Application/Control No. 10/046,240 Examiner Jay L Politzer Applicant(s)/Patent Under Reexamination CHEN ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,496,781	12-2002	Chen et al.	702/25
	В	US-			
	C	US-			
	D	US-		·	
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-		-	س
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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